



## Description

The SSM3J358R,LF uses advanced trench technology

to provide excellent  $R_{DS(ON)}$ , low gate charge and

operation with gate voltages as low as 2.5V.

This device is suitable for use as a Battery protection or in other Switching application.

## General Features

$V_{DS} = -20V, I_D = -7A$

$R_{DS(ON)} < 26m\Omega @ V_{GS}=4.5V$

## Application

High power and current handing capability

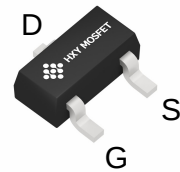
Lead free product is acquired

Surface mount package

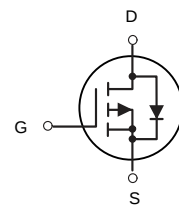
PWM applications

Load switch

Power management



SOT-23-3L  
(SOT-23F)



P-Channel MOSFET

## Package Marking and Ordering Information

| Product ID   | Pack               | Brand      | Qty(PCS) |
|--------------|--------------------|------------|----------|
| SSM3J358R,LF | SOT-23-3L(SOT-23F) | HXY MOSFET | 3000     |

## Absolute Maximum Ratings ( $T_A=25^{\circ}C$ unless otherwise noted)

| Symbol          | Parameter                                                   | Limit      | Unit          |
|-----------------|-------------------------------------------------------------|------------|---------------|
| $V_{DS}$        | Drain-Source Voltage                                        | -20        | V             |
| $V_{GS}$        | Gate-Source Voltage                                         | $\pm 12$   | V             |
| $I_D$           | Drain Current-Continuous                                    | -7         | A             |
| $I_{DM}$        | Drain Current-Pulsed <sup>(Note 1)</sup>                    | -18.8      | A             |
| $P_D$           | Maximum Power Dissipation                                   | 1          | W             |
| $T_J, T_{STG}$  | Operating Junction and Storage Temperature Range            | -55 To 150 | $^{\circ}C$   |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient <sup>(Note 2)</sup> | 125        | $^{\circ}C/W$ |



Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

| Symbol                       | Parameter                                      | Conditions                                                    | Min. | Typ.  | Max.      | Unit                 |
|------------------------------|------------------------------------------------|---------------------------------------------------------------|------|-------|-----------|----------------------|
| $BV_{DSS}$                   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V$ , $I_D=-250\mu A$                                 | -20  | ---   | ---       | V                    |
| $\Delta BV_{DSS}/\Delta T_J$ | BVDSS Temperature Coefficient                  | Reference to $25^\circ\text{C}$ , $I_D=-1mA$                  | ---  | -0.01 | ---       | V/ $^\circ\text{C}$  |
| $R_{DS(ON)}$                 | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=-4.5V$ , $I_D=-6.5A$                                  | ---  | 20    | 26        | $m\Omega$            |
|                              |                                                | $V_{GS}=-2.5V$ , $I_D=-5A$                                    | ---  | 34    | 40        |                      |
|                              |                                                | $V_{GS}=-1.8V$ , $I_D=-1.5A$                                  | ---  | ---   | ---       |                      |
| $V_{GS(th)}$                 | Gate Threshold Voltage                         | $V_{GS}=V_{DS}$ , $I_D=-250\mu A$                             | -0.6 | -0.8  | -1.4      | V                    |
| $\Delta V_{GS(th)}$          | $V_{GS(th)}$ Temperature Coefficient           |                                                               | ---  | ---   | ---       | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                    | Drain-Source Leakage Current                   | $V_{DS}=-20V$ , $V_{GS}=0V$ , $T_J=25^\circ\text{C}$          | ---  | ---   | -1        | $\mu A$              |
|                              |                                                | $V_{DS}=-16V$ , $V_{GS}=0V$ , $T_J=55^\circ\text{C}$          | ---  | ---   | ---       |                      |
| $I_{GSS}$                    | Gate-Source Leakage Current                    | $V_{GS}=\pm 12V$ , $V_{DS}=0V$                                | ---  | ---   | $\pm 100$ | nA                   |
| $g_{fs}$                     | Forward Transconductance                       | $V_{DS}=-5V$ , $I_D=-3A$                                      | ---  | 10    | ---       | S                    |
| $Q_g$                        | Total Gate Charge (-4.5V)                      | $V_{DS}=-10V$ , $V_{GS}=-4.5V$ , $I_D=-6.5A$                  | ---  | 10    | ---       | nC                   |
| $Q_{gs}$                     | Gate-Source Charge                             |                                                               | ---  | 1.5   | ---       |                      |
| $Q_{gd}$                     | Gate-Drain Charge                              |                                                               | ---  | 3     | ---       |                      |
| $T_{d(on)}$                  | Turn-On Delay Time                             | $V_{DD}=-10V$ , $V_{GS}=-4.5V$ , $R_G=6.0\Omega$<br>$I_D=-1A$ | ---  | 30    | ---       | ns                   |
| $T_r$                        | Rise Time                                      |                                                               | ---  | 25    | ---       |                      |
| $T_{d(off)}$                 | Turn-Off Delay Time                            |                                                               | ---  | 70    | ---       |                      |
| $T_f$                        | Fall Time                                      |                                                               | ---  | 50    | ---       |                      |
| $C_{iss}$                    | Input Capacitance                              | $V_{DS}=-10V$ , $V_{GS}=0V$ , $f=1MHz$                        | ---  | 1210  | ---       | pF                   |
| $C_{oss}$                    | Output Capacitance                             |                                                               | ---  | 310   | ---       |                      |
| $C_{rss}$                    | Reverse Transfer Capacitance                   |                                                               | ---  | 290   | ---       |                      |
| $I_S$                        | Continuous Source Current <sup>1,4</sup>       | $V_G=V_D=0V$ , Force Current                                  | ---  | ---   | -7.0      | A                    |
| $I_{SM}$                     | Pulsed Source Current <sup>2,4</sup>           |                                                               | ---  | ---   | -18.8     | A                    |
| $V_{SD}$                     | Diode Forward Voltage <sup>2</sup>             | $V_{GS}=0V$ , $I_S=-1A$ , $T_J=25^\circ\text{C}$              | ---  | ---   | -1        | V                    |
| $t_{rr}$                     | Reverse Recovery Time                          | $I_F=-4A$ , $dI/dt=100A/\mu s$ , $T_J=25^\circ\text{C}$       | ---  | 52    | ---       | nS                   |
| $Q_{rr}$                     | Reverse Recovery Charge                        |                                                               | ---  | 28    | ---       | nC                   |

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
4. The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.



## Typical Characteristics

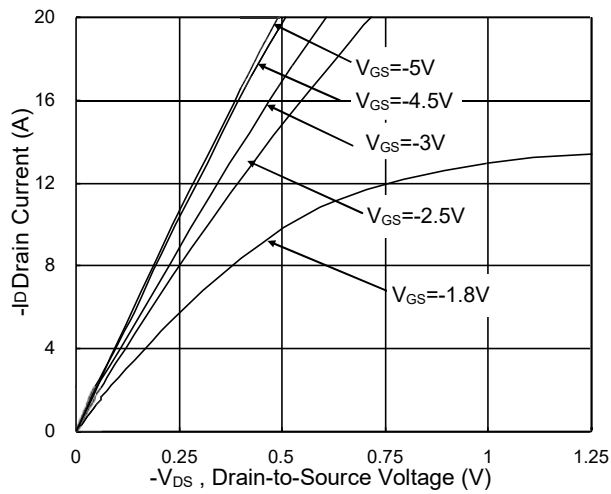


Fig.1 Typical Output Characteristics

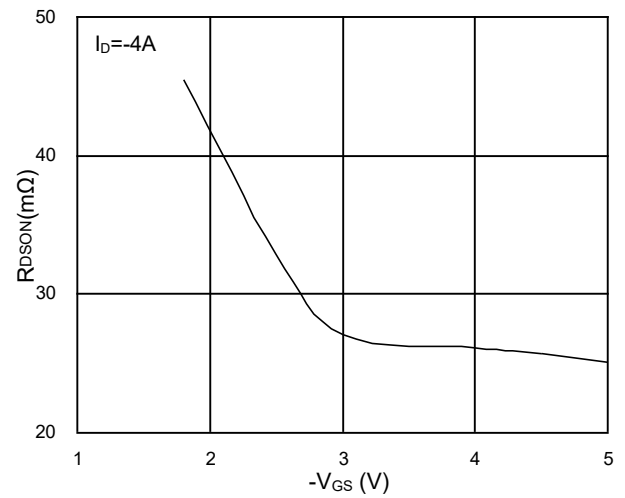


Fig.2 On-Resistance vs. Gate-Source

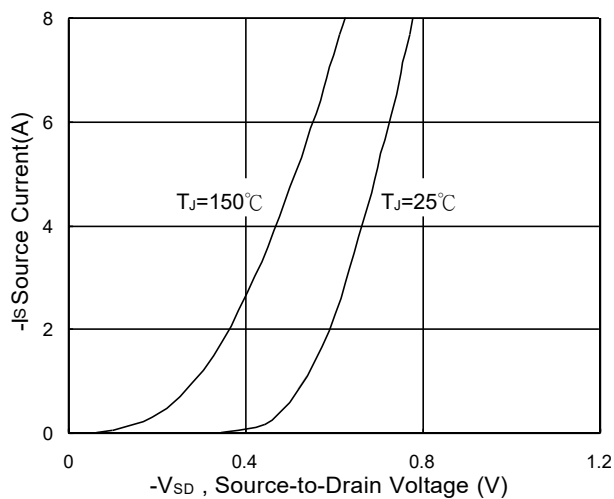


Fig.3 Forward Characteristics Of Reverse

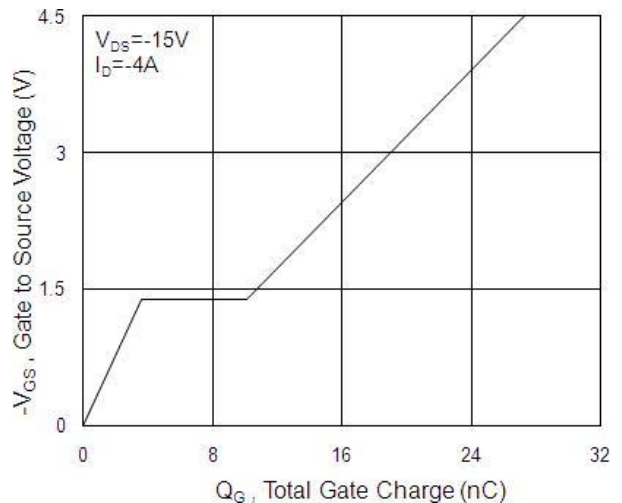


Fig.4 Gate-Charge Characteristics

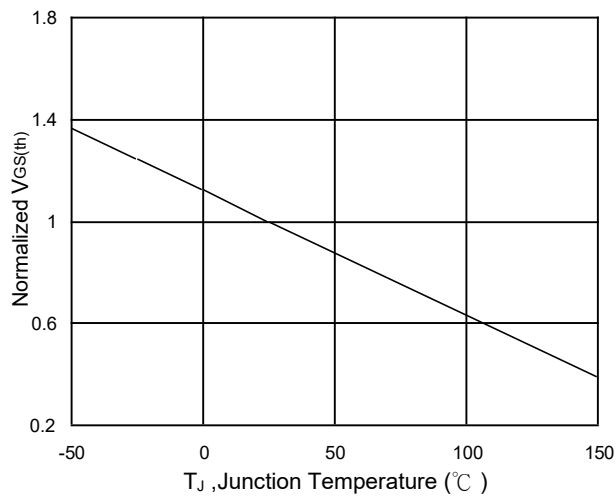


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$

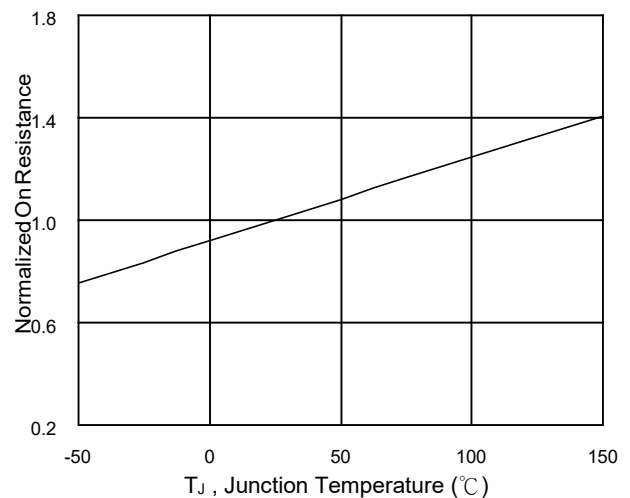


Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$

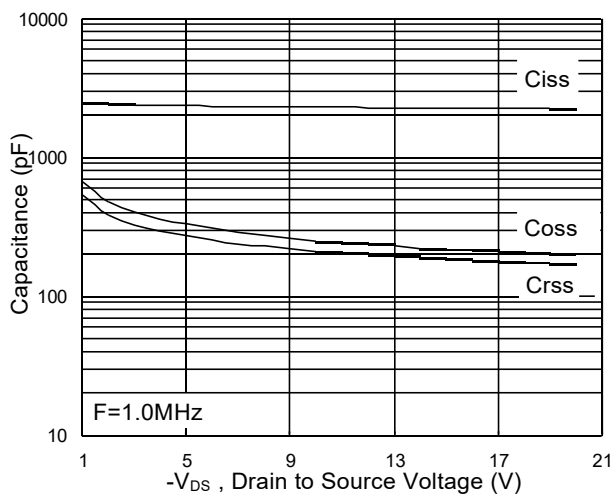


Fig.7 Capacitance

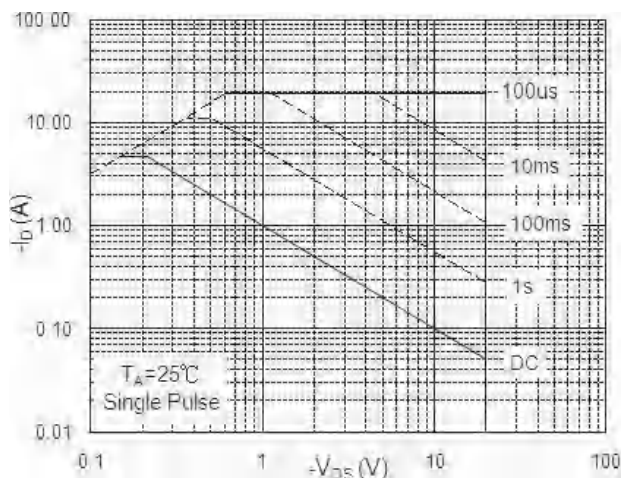


Fig.8 Safe Operating Area

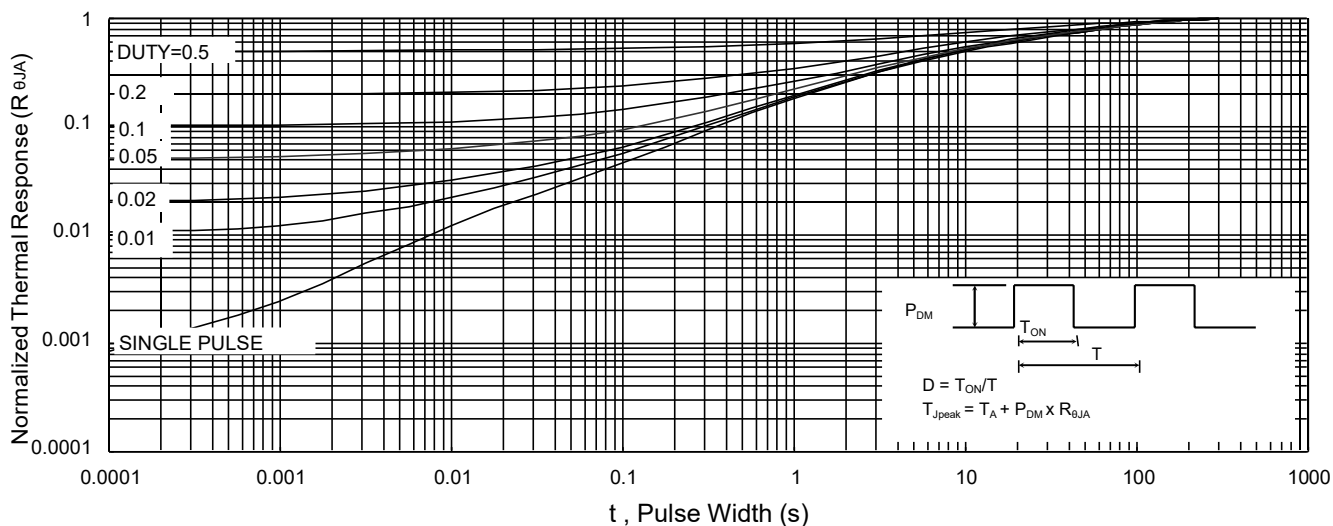


Fig.9 Normalized Maximum Transient Thermal Impedance

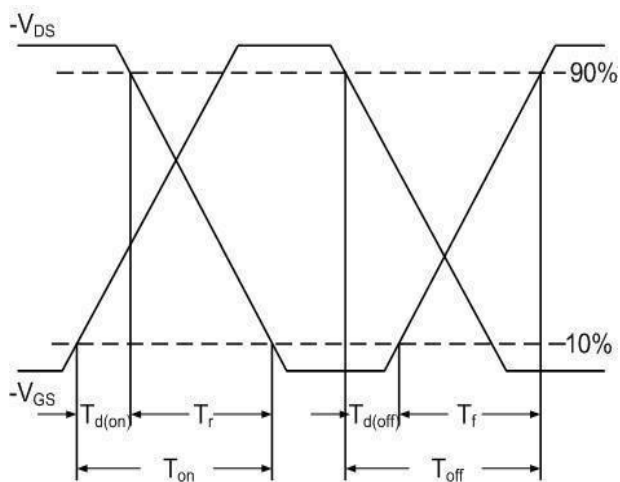


Fig.10 Switching Time Waveform

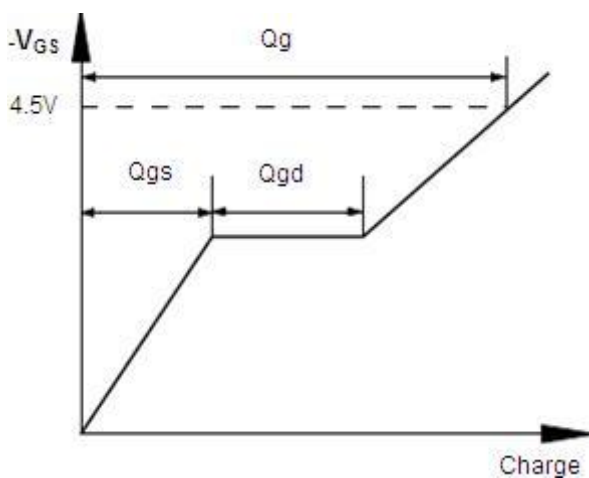
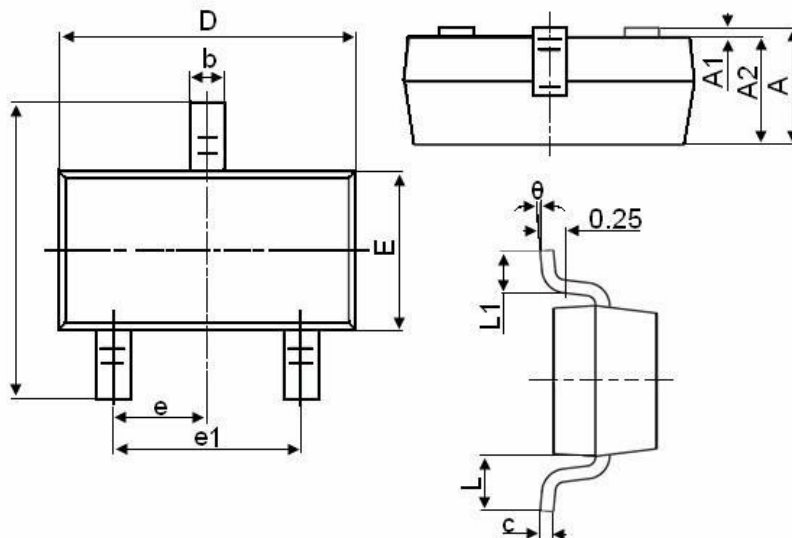


Fig.11 Gate Charge Waveform



## SOT-23-3L(SOT-23F) Package Information



| Symbol | Dimensions in Millimeters |       |
|--------|---------------------------|-------|
|        | MIN.                      | MAX.  |
| A      | 1.050                     | 1.250 |
| A1     | 0.000                     | 0.100 |
| A2     | 1.050                     | 1.150 |
| b      | 0.300                     | 0.500 |
| c      | 0.100                     | 0.200 |
| D      | 2.800                     | 3.000 |
| E      | 1.500                     | 1.700 |
| E1     | 2.650                     | 2.950 |
| e      | 0.950TYP                  |       |
| e1     | 1.800                     | 2.000 |
| L      | 0.550REF                  |       |
| L1     | 0.300                     | 0.600 |
| θ      | 0°                        | 8°    |



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